

E050190 -B- D

Drawing No

## **SPECIFICATION**

Sheet 1 2 of

Rev. Group

# Final Polish, LASTI End Test Mass (ETM)

			APPROVALS		
AUTHOR:	CHECKED:	DATE	DCN NO.	REV	DATE
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## **Applicable Documents**

LIGO-D040431-C	Quad ETM Silica Test Mass
<u>LIGO-E030309</u> -A	Fused Silica Blank, LASTI Test Mass, R&D
LIGO-E050191-A	Shape and Polish LASTI ETM Blank
MIL-PRF-13830B	General Specification Governing the Manufacture, Assembly, and Inspection of Optical Components for Fire Control Instruments

## **Requirements**

### **Physical Configuration**

According to LIGO-D040431 Quad ETM Silica Test Mass, X dimension  $200.0 \pm 0.5$  millimeters

Fabricate from LIGO-E050191 Shape and Polish LASTI ETM blank LIGO-E030309 Fused Silica Blank, LASTI Test Mass, R&D

#### Optical Surface Figure, Sides 1 and 2 - FLAT. Measured over the central 120 mm diameter

**Surface 1:** Flat to  $< \lambda/10$  Peak to Valley, measured at 633 nm

**Surface 2:** Flat to  $< \lambda/3$  Peak to Valley, measured at 633 nm

### Surface Error, High Spatial Frequency: "microroughness" measured over the central 120 mm diameter

Surface 1 HSF error  $\sigma_{rms} \leq 0.2$  nanometers

Surface 2 : not specified



LASER INTERFEROMETER GRAVITATIONAL WAVE OBSERVATORY

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### Scratches, Sleeks and Point defects

Scratches, sleeks and point defects are evaluated according to MIL-PRF-13830B

#### Side 1

Within the central 20mm diameter: 10/5 Within the central 120 mm diameter: 20/10 Outside the central 120 mm diameter: 40/20

#### Side 2

Within the central 120 mm diameter: 40/20

### Inspection

Specification	Test Method	Data Delivered
Scratches and Point defects, side	Visual Inspection	Certification
one		
Figure, side one	Interferometry	Surface phase map
Surface Errors - High Spatial	Interferometry	Surface maps for 3 central locations. Numerical values
frequency, side one		included with certification

 Table 1: Inspections

Orientation: For the purpose of phase maps the substrate shall be oriented such that the point of minimum thickness shall be at the top center of the data.